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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/511,021	AHRNDT ET AL.		
Examiner	Art Unit		
Quoc D. Tran	2614		

SEARCHED				
Class	Subclass	Date	Examiner	
379	1.01	9/22/2007	QT	
	1.03	,		
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	22.01			
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	22.07			
	23			
	24			
	29.01			
	29.03			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
EAST		9/22/2007	QΤ
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